

# **FDG6306P**

# P-Channel 2.5V Specified PowerTrench® MOSFET

## **General Description**

This PChannel 2.5V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V – 12V).

### **Applications**

- Battery management
- · Load switch

#### **Features**

- -0.6 A, -20 V.  $R_{DS(ON)} = 420 \text{ m}\Omega$  @  $V_{GS} = -4.5 \text{ V}$  $R_{DS(ON)} = 630 \text{ m}\Omega$  @  $V_{GS} = -2.5 \text{ V}$
- · Low gate charge

S 1 or

G 2 or 5

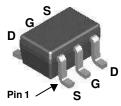
D 3 or 6

- High performance trench technology for extremely low Resident
- Compact industry standard SC70-6 surface mount package

6 or 3 D

5 or 2 G

4 or 1 S



SC70-6

The pinouts are symmetrical; pin 1 and pin 4 are interchangeable.

## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage		± 12	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1)	-0.6	Α
	– Pulsed		-2.0	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1)	0.3	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

## **Thermal Characteristics**

R <sub>0JA</sub> Thermal Resistance	Junction-to-Ambient	(Note 1)	415	°C/W
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## **Package Marking and Ordering Information**

Device Marking Device		Reel Size	Tape width	Quantity	
.06	FDG6306P	7"	8mm	3000 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					I.
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_D = -250 \ \mu\text{A}$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = –250 μA, Referenced to 25°C		-14		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, \ V_{GS} = 0 \text{ V}$			-1	μΑ
GSSF	Gate-Body Leakage, Forward	$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
l <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = 12 \text{ V},  V_{DS} = 0 \text{ V}$			100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	-0.6	-1.2	-1.5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$ , Referenced to 25°C		3		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -0.6 A V <sub>GS</sub> = -2.5 V, I <sub>D</sub> = -0.5 A V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -0.6 A, T <sub>J</sub> =125 °C		300 470 400	420 630 700	МΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-2			Α
<b>g</b> FS	Forward Transconductance	$V_{DS} = -5 \text{ V},  I_D = -0.6 \text{ A}$		1.8		S
Dynamic	Characteristics					
Ciss	Input Capacitance	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		114		pF
Coss	Output Capacitance	f = 1.0 MHz		24		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			9		pF
Switchir	ng Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, I_D = 1 \text{ A},$		5.5	11	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		14	25	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			6	12	ns
t <sub>f</sub>	Turn-Off Fall Time			1.7	3.4	ns
Qg	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -0.6 \text{ A},$		1.4	2.0	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		0.3		nC
$Q_{gd}$	Gate-Drain Charge			0.4		nC
Drain–S	ource Diode Characteristic	s and Maximum Ratings				
ls	Maximum Continuous Drain-Source				-0.25	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \qquad I_S = -0.25 \text{ A}(\text{Note 2})$		-0.77	-1.2	V

#### Notes

<sup>1.</sup>  $R_{0JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{0JC}$  is guaranteed by design while  $R_{0JA}$  is determined by the user's board design.  $R_{0JA} = 415\,^{\circ}\text{C/W}$  when mounted on a minimum pad.

<sup>2.</sup> Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%

# **Typical Characteristics**

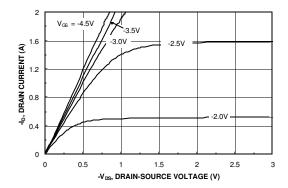


Figure 1. On-Region Characteristics.

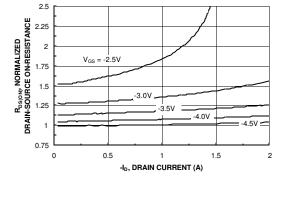


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

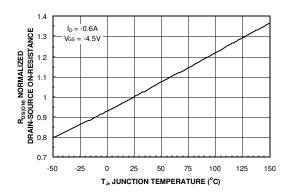


Figure 3. On-Resistance Variation with Temperature.

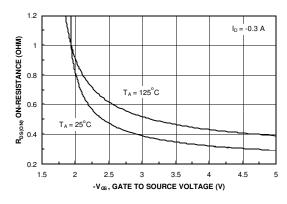


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

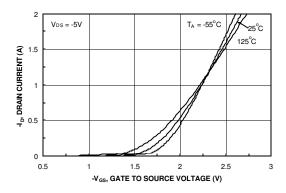


Figure 5. Transfer Characteristics.

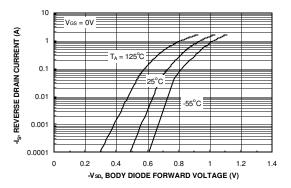
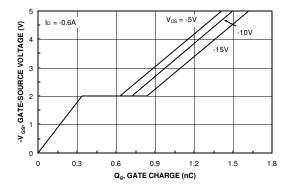


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**



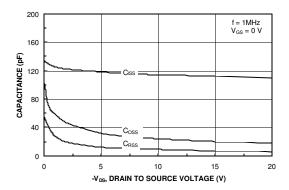


Figure 7. Gate Charge Characteristics.

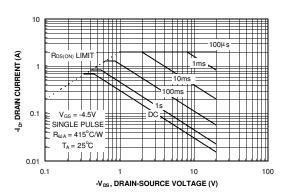


Figure 8. Capacitance Characteristics.

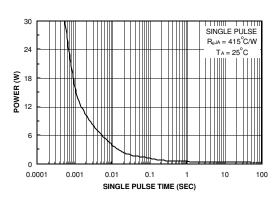


Figure 9. Maximum Safe Operating Area.



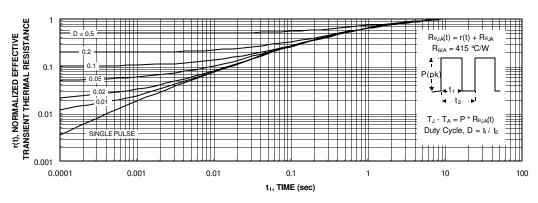


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1. Transient thermal response will change depending on the circuit board design.

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DOME™ Quiet Series™ ISOPLANAR™ E<sup>2</sup>CMOS<sup>TM</sup> MICROWIRE™ SILENT SWITCHER® EnSigna™ **OPTOLOGIC™** SMART START™ FACT™ **OPTOPLANAR™** SuperSOT™-3 FACT Quiet Series™ PACMAN™ SuperSOT™-6 **РОР**ТМ SuperSOT™-8 FAST®

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